


<b>Search Notes</b> 	<b>Application/Control No.</b> 10618227	<b>Applicant(s)/Patent Under Reexamination</b> PAN ET AL.
	<b>Examiner</b> Pathak, Sudhanshu C	<b>Art Unit</b> 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	260	2/3/2008	SP
	347		
	130		
	340		
	222		
370	210	2/3/2008	SP
	203		
711	5	2/3/2008	

SEARCH NOTES		
Search Notes	Date	Examiner
east	2/3/2008	SP
IEEE Xplore	2/3/2008	SP
Inventor Name Search	2/3/2008	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner